Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/722,512	SHINJO ET AL.	
Examiner	Art Unit	
Christopher RoDee	1756	

	SEARCHED		
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	137.19	6/20/2005	CDR
430	137.22	6/20/2005	CDR
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
search updated		6/20/2005	CDR